

11-1-2005

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## Recommended Citation

Ng, Vee Ming (2005) "Inference for  $P(Y$ " *Journal of Modern Applied Statistical Methods*: Vol. 5 : Iss. 2 , Article 5.

DOI: 10.22237/jmasm/1162353840

Available at: <http://digitalcommons.wayne.edu/jmasm/vol5/iss2/5>

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## Inference for $P(Y < X)$ for Exponential and Related Distributions

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Some tests and confidence bounds for the reliability parameter  $R=P(Y < X)$  are proposed, where  $X$  and  $Y$  are independent random variables from a two-parameter exponential distribution. The results are based on missing or incomplete data and are applicable to some related distributions.

Key words - Confidence bounds, exponential distribution, missing data, P-value, reliability parameter

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### Introduction

The problem of estimating and testing the reliability parameter  $R=P(Y < X)$  has been widely researched in the literature. The problem originated in the context of reliability of a component of strength  $X$  subjected to a stress  $Y$ , the component failing if and only if at any time the applied stress is greater than its strength. Other applications for the reliability parameter exists when  $X$  and  $Y$  have different interpretation, such as when  $Y$  is the response for a control group and  $X$  is the response for the treatment group. Inference on  $R$  shall be considered when  $X$  and  $Y$  are random variables from a two-parameter exponential distribution. Inference on  $R$  for the one-parameter exponential distribution can be found in Enis and Geisser (1971), Tong (1977), and Chao (1982) among others.

Gupta and Gupta (1988) derived and compared some point estimators for  $R$  in the case of two independent exponential variables having a common scale parameter. For the case in which the location parameter is common, Bai

and Hong (1992) discussed point and interval estimation of  $R$  and Baklizi (2003) compared the performance of several types of asymptotic, approximate, and bootstraps confidence intervals. Ali, Woo, and Pal (2004) considered test and estimation of  $R$  when the scale parameters are equal and known and also inference procedures for  $R$  which are based on likelihood ratio tests for equality of scale and equality of location parameters.

This article considers some tests and confidence bounds for  $P\{Y < X\}$  for the two-parameter exponential distribution with a common but unknown scale parameter and also with a common but unknown location parameter. Exact tests and confidence bounds are derived in situations where data may be missing or incomplete, the situation with complete data being a special case. These results are extended to some related distributions.

### Methodology and Results

A two-parameter exponential distribution with parameters  $(\mu, \sigma)$  is defined by the probability density function:

$$f(x; \mu, \sigma) = \frac{1}{\sigma} e^{-(x-\mu)/\sigma}, \quad x > \mu, \quad \sigma > 0$$

Suppose  $X$  and  $Y$  are independent exponential random variables with parameters  $(\mu_x, \sigma_x)$  and  $(\mu_y, \sigma_y)$  and probability density

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functions  $f(x; \mu_x, \sigma_x)$  and  $f(y; \mu_y, \sigma_y)$  respectively. Then

$$R \equiv P(Y < X) = \int \int_{\mu_y < y < x} f(x; \mu_x, \sigma_x) f(y; \mu_y, \sigma_y) dy dx = \left\{ \begin{array}{l} \frac{\sigma_x}{\sigma_x + \sigma_y} e^{-\delta / \sigma_x}, \delta \geq 0 \\ 1 - \frac{\sigma_y}{\sigma_x + \sigma_y} e^{\delta / \sigma_y}, \delta < 0 \end{array} \right\}$$

where  $\delta = \mu_y - \mu_x$ . Inference on R is considered for two cases: (a) scale parameters are equal and unknown and (b) location parameters are equal and unknown.

Assuming two independent samples of size n and m from the exponential distributions with parameters  $(\mu_x, \sigma_x)$  and  $(\mu_y, \sigma_y)$  respectively, let  $X_q < X_{q+1} < \dots < X_r$  and  $Y_l < Y_{l+1} < \dots < Y_p$  denote the ordered observations; some of these could be missing where  $q=1, r=n$ , and  $l=1, p=m$  would correspond to all observations being available.

Let  $S_x = \sum_{i=q+1}^r c_i (n-i+1)(X_i - X_{i-1})$   $c_i = 1$

or  $0; S_y = \sum_{j=l+1}^p d_j (m-j+1)(Y_j - Y_{j-1})$

$d_j = 1$  or  $0$ , and  $S_p = S_x + S_y, v_x = \sum_{i=q+1}^r c_i,$

$v_y = \sum_{j=l+1}^p d_j, v = v_x + v_y.$  It is well known

that:

- $X_q, Y_l, S_x, S_y, S_p$  are statistically independent (see Tanis (1964), Likes (1974)).
- $2S_x / \sigma_x, 2S_y / \sigma_y, 2S_p / \sigma$  when  $\sigma_x = \sigma_y = \sigma,$  have chi-square distributions with  $2v_x, 2v_y, 2v$  degrees of freedom respectively.

- The probability density functions of the ordered statistics  $X_q$  and  $Y_l$  can be written, respectively, as

$$f(x; \mu_x, \sigma_x, n, q) = \sum_{i=0}^{q-1} a(n, q, i) \frac{1}{\sigma_x} e^{-n(q,i)(x-\mu_x)/\sigma_x}$$

$$f(y; \mu_y, \sigma_y, m, l) = \sum_{j=0}^{l-1} b(m, l, j) \frac{1}{\sigma_y} e^{-m(l,j)(y-\mu_y)/\sigma_y}$$

where

$$a(n, q, i) = q \binom{n}{q} \binom{q-1}{i} (-1)^i,$$

$$b(m, l, j) = l \binom{m}{l} \binom{l-1}{j} (-1)^j,$$

$$n(q, i) = n - q + i + 1,$$

$$m(l, j) = m - l + j + 1.$$

Test of hypothesis when  $\sigma_x = \sigma_y = \sigma$

Suppose that  $\sigma_x = \sigma_y = \sigma$  but  $\sigma$  is unknown, then

$$R = \left\{ \begin{array}{l} \frac{1}{2} e^{-\lambda}, \lambda \geq 0 \\ 1 - \frac{1}{2} e^{-\lambda}, \lambda < 0 \end{array} \right\}$$

where

$$\lambda = (\mu_y - \mu_x) / \sigma.$$

A test procedure is now derived for testing hypotheses about the reliability parameter R; a similar procedure is considered in Ranganathan and Kale (1979) for a 1-sample reliability problem. Because  $P(X<Y)=1-R,$  it suffices to consider the problem of testing the null hypothesis  $H_0 : \frac{1}{2} e^{-\lambda} \geq p_0,$  against the

alternative  $H_1 : \frac{1}{2}e^{-\lambda} < p_0$ ,  $p_0$  being a specified value less than 0.5. As these hypotheses are equivalent to  $H_0 : \lambda \geq -\ln(2p_0)$  against  $H_1 : \lambda < -\ln(2p_0)$ , consider the test statistic  $T = (Y_l - X_q) / S_p$ . T is a maximal invariant and its distribution depends only on  $\lambda$ . A large value of T would be evidence against  $H_0$ . Hence, for an observed value t of T,  $P(T > t)$  for  $t \geq 0$ ,  $\lambda \geq 0$  is the P-value of the test, a small value of which would indicate sufficient evidence against  $H_0$ . In order to get an expression for the P-value, one must first obtain, from the joint of density function of  $X_q, Y_l, S_p$ , the joint probability density function of  $D = Y_l - X_q$  and  $S_p$ ,  $f(d, s; \delta, \sigma)$ , which then yields the joint of density function  $f(t, w; \lambda)$  of  $T = D / S_p$  and  $W = S_p / \sigma$ :

$$f(d, s; \delta, \sigma) = \left\{ \begin{array}{l} \sum_{i=0}^{q-1} \sum_{j=0}^{l-1} \frac{a(n, q, i)b(m, l, j)e^{m(l, j)\delta/\sigma} s^{v-1} e^{-[m(l, j)d+s]/\sigma}}{\Gamma(v)[n(q, i) + m(l, j)]\sigma^{v+1}} \\ , d \geq \delta, s \geq 0 \\ \sum_{i=0}^{q-1} \sum_{j=0}^{l-1} \frac{a(n, q, i)b(m, l, j)e^{-n(q, i)\delta/\sigma} s^{v-1} e^{-[n(q, i)d-s]/\sigma}}{\Gamma(v)[n(q, i) + m(l, j)]\sigma^{v+1}} \\ , d < \delta, s \geq 0 \end{array} \right\}$$

$$f(t, w; \lambda) = \left\{ \begin{array}{l} \sum_{i=0}^{q-1} \sum_{j=0}^{l-1} \frac{a(n, q, i)b(m, l, j)e^{m(l, j)\lambda} w^v e^{-w[m(l, j)t+1]}}{\Gamma(v)[n(q, i) + m(l, j)]} \\ , tw \geq \lambda, w \geq 0 \\ \sum_{i=0}^{q-1} \sum_{j=0}^{l-1} \frac{a(n, q, i)b(m, l, j)e^{-n(q, i)\lambda} w^v e^{-w[n(q, i)t-1]}}{\Gamma(v)[n(q, i) + m(l, j)]} \\ , tw < \lambda, w \geq 0 \end{array} \right\}$$

The P-value,  $P(T > t)$  is obtained from  $f(t, w; \lambda)$ ,  $tw \geq \lambda, w \geq 0$  as

$$P(T > t) = \sum_{i=0}^{q-1} \sum_{j=0}^{l-1} \int_t^\infty \int_{\lambda[m(l, j)+1/u]}^\infty \frac{a(n, q, i)b(m, l, j)e^{m(l, j)\lambda} z^v e^{-z}}{\Gamma(v)[n(q, i) + m(l, j)] [1+m(l, j)u]^{v+1}} dz du$$

Integration by parts yields

$$P(T > t) = \sum_{i=0}^{q-1} \sum_{j=0}^{l-1} \frac{a(n, q, i)b(m, l, j)}{m(l, j)[n(q, i) + m(l, j)]} \left\{ \begin{array}{l} \frac{e^{m(l, j)\lambda}}{(1+m(l, j)t)^v} P(G > \lambda[m(l, j)+1/t]) \\ + P(G < \lambda/t) \end{array} \right\}$$

where G the Gamma random variable with shape parameter  $v + 1$ .

In many situations the first ordered statistics are available i.e.  $q = 1, l = 1$  and the above simplifies to

$$P(T > t) = \frac{n}{n+m} \left\{ \begin{array}{l} \frac{e^{m\lambda}}{(1+mt)^v} P(G > \lambda[m+1/t]) \\ + P(G < \lambda/t) \end{array} \right\}$$

Point estimators of R for the case  $q = 1, l = 1$  are considered in Gupta and Gupta (1988) where the maximum likelihood estimator of R is obtained with  $T/(m+n)$  as an estimator of  $\lambda$  in the equation for R.

Inference when  $\mu_x = \mu_y = \mu$

When  $\mu_x = \mu_y = \mu$  but  $\mu$  is unknown then R reduces to

$$\theta \equiv \frac{\sigma_x}{\sigma_x + \sigma_y}$$

Consider the null hypothesis  $H_0 : \theta \geq q_0$  or equivalently  $H_0 : \frac{\sigma_x}{\sigma_y} \geq \frac{q_0}{1 - q_0}$  where  $q_0$  is a specified probability.  $2S_x / \sigma_x$  and  $2S_y / \sigma_y$  are independently distributed as chi-square with  $2v_x$  and  $2v_y$  degrees of freedom and  $\frac{S_x / (v_x \sigma_x)}{S_y / (v_y \sigma_y)}$  has a F distribution with  $v_x$  and  $v_y$  degrees of freedom. Hence, one can use  $F = \frac{S_x v_y (1 - q_0)}{S_y v_x q_0}$  as the test statistic.

An estimate of  $\theta$  is  $\hat{\theta} = \frac{S_x / v_x}{S_x / v_x + S_y / v_y}$ . A  $(1 - \alpha)$  confidence interval for  $\theta$  is obtainable from the F distribution with  $v_x$  and  $v_y$  degrees of freedom via  $P\{F_l < \frac{S_x \sigma_y v_y}{S_y \sigma_x v_x} < F_u\}$  where  $F_l$  and  $F_u$  satisfies  $1 - \alpha = P\{F_l < F < F_u\}$ . The confidence interval can be written, after some algebraic manipulation, as

$$\left( \frac{\hat{\theta}}{\hat{\theta} + (1 - \hat{\theta})F_u}, \frac{\hat{\theta}}{\hat{\theta} + (1 - \hat{\theta})F_l} \right)$$

When complete samples are available,  $S_x = \sum_{i=2}^n (X_i - X_1)$ ,  $S_y = \sum_{j=2}^m (Y_j - Y_1)$  one of which is slightly different from those used in Bai and Hong (1992). They used  $\sum_{i=1}^n (X_i - \min(X_1, Y_1))$   $\sum_{j=1}^m (Y_j - \min(X_1, Y_1))$  instead of  $S_x$ ,  $S_y$  respectively and obtained approximate confidence interval based on a mixed beta distribution.

Applications to Related Distributions

Suppose X and Y are independent two-parameter exponential random variables and  $\varphi$  is a monotonic function with inverse  $\varphi^{-1}$ . Because

$$P(Y < X) = P(\varphi(Y) < \varphi(X))$$

the tests and confidence bounds developed in the previous sections are also applicable to the variables  $\varphi(X)$  and  $\varphi(Y)$ ; the results are to be applied after making the transformation,  $\varphi$ , to the observations. The results are applicable to the Rayleigh distribution with  $\varphi(X) = \sqrt{2X}$ ,  $\varphi^{-1}(X) = X^2 / 2$  and the Pareto distribution with  $\varphi(X) = \exp(X)$ ,  $\varphi^{-1}(X) = \ln(X)$ .

Numerical example

Suppose a system has two main parts, Y and X, whose lifetimes are exponentially distributed. Suppose  $m=n=15$  component parts are put on test simultaneously and the failure times are {106, 108, 109, 113, 116, 126, 127, 132, 138, 141, 147, 164, 185, 202, 285} and {79, 82, 88, 89, 91, 107, 112, 118, 133, 149, 165, 167, 170, 202, 222} for Y and X respectively. Then  $l=q=1$ ,  $c_i, d_j = 1$  for  $i = j = 1, 2, \dots, 15$ ,  $t = 0.0193$ ,  $s_y = 609$ ,  $s_x = 789$ , and  $v_x = v_y = 14$ . To test whether system failure may be equally likely due to either part, the test of  $H_0 : \lambda \geq 0$  ( $R \geq 0.5$ ) against  $H_1 : \lambda < 0$  yields a P-value of 0.0004 which is sufficient evidence that X is more likely to fail before Y. If instead one is interested to test, say,  $H_0 : R = \frac{1}{2} e^{-\lambda} \geq 0.4$  against  $H_1 : R < 0.4$  then the P-value is 0.011. There is sufficient evidence to reject  $H_0$ ; the probability that system failure will be due to Y is less than 0.4. If, for example, the values 108

and 109 for Y are missing, then one would set  $d_2 = d_3 = 0$  and the recalculated values for the test of  $H_0 : R \geq 0.4$  are  $t = 0.0199$ ,  $s_y = 568$ , and  $v_y = 12$  with a P-value equal 0.016.

#### Conclusion

Tests of hypotheses and confidence bounds for R have been developed for the two-parameter exponential distribution in two cases, namely one involving a common scale parameter and the other a common location parameter. Exact tests for the two cases are derived for situations in which data may be missing or incomplete. Exact confidence bounds for R in the common location case are also proposed and they provide an alternative to the approximate bounds that have been considered in a complete sample situation. Furthermore, these results are applicable to a larger class of distributions which includes the Raleigh and the Pareto distributions.

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